

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10773496	CHAN ET AL.
Examiner	Art Unit	
Myhre, James W	3622	

SEARCHED

Class	Subclass	Date	Examiner
705	14	04/21/2011	dp

SEARCH NOTES

Search Notes	Date	Examiner
EAST Search (USPAT, US PgPub, JPO, EPO, DERWENT, IBM TB) (attached)	1/4/08	
NPL (attached)	04/21/2011	dp

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
705	14.51	04/21/2011	dp
707	104.1	04/21/2011	dp